Construction of Mixed-Level Orthogonal Arrays for Testing in Digital Marketing

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Advantages of Conducting Designed Experiments in Digital Marketing

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- Availability of Data
- Ease of Creating Tests
- Automation of the Analysis

Challenges of Conducting Designed Experiments in Digital Marketing

 Wide Range of Factor-Level Combinations, Including Mixed-Level Designs

- Binary and continuous response variable
- Designs Must Be Small
- Designs Must Be Robust
- Must Isolate Effects
- Must Produce Results Fast
- Unsophisticated Users Robustness

- Motivation
- Fractional Factorial Design
- Clear Effects
- Minimum Aberration Criterion
- Orthogonal Array Construction

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Conclusion

Fractional Factorial Design

Motivation: for economic reasons, full factorial designs are seldom used in practice for large k ($k \ge 7$). **Fractional Factorial Design**: a subset or fraction of full factorial designs.

 "Optimal" fractions: are chosen according to the resolution or minimum aberration criteria.

 Aliasing of effects: a price one must pay for choosing a smaller design.

Design r^{k-p} , where

- r: level of the factors.
- k: number of the factors.
- p: number of design generators.
- ▶ $n = r^{k-p}$: run size.

An Example

No.	A	В	С	D	Е
1	_	+	+	_	_
2	+	+	+	+	_
3	_	_	+	+	_
4	+	_	+	_	_
5	_	+	_	+	_
6	+	+	_	—	_
7	_	_	_	—	_
8	+	—	—	+	_
9	_	+	+	—	+
10	+	+	+	+	+
11	_	_	+	+	+
12	+	_	+	—	+
13	_	+	—	+	+
14	+	+	_	—	+
15	—	_	_	_	+
16	+	_	_	+	+

Two key properties of the designs: balance and orthogonality.

- Balance: Each factor level appears in the same number of runs.
- Orthogonality: Two factors are called orthogonal if all their level combinations appear in the same number of runs. A design is called orthogonal if all pairs of its factors are orthogonal.

Design Generators

- ▶ 2⁵⁻¹ design: 16 runs, which is a ¹/₂ fraction of a 2⁵ full factorial design.
- ► Aliasing: D and ABC, i.e., main effect of D is aliased with the A × B × C interaction.
- The aliasing is denoted by the **design generator** D = ABC, $x_4 = x_1 + x_2 + x_3 \pmod{2}$.
- Since 2x₄ = x₁ + x₂ + x₃ + x₄ = 0 (mod 2), we can get the defining relation *I* = *ABCD* (*I* = 1234).

	Number	Factors
Main effects	5	A,B,C,D,E
Two-factor	10	AB,AC,AD,AE,BC,,DE
Three-factor	10	ABC,ABD,ABE,BCD,,CDE
Four-factor	5	ABCD,ABCE,ABDE,ACDE,BCDE
Five-factor	1	ABCDE

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Clear Main Effects and Two-factor Interaction Effects

Clear effect: a main effect or two-factor interaction is clear if none of its aliases are main effects or two-factor interactions.

	Number	Factors		
Main effects	5	A,B,C,D,E		
Two-factor	4	AE,BE,CE,DE		

From $x_1 + x_2 + x_3 + x_4 = 0 \pmod{2}$, we can get:

- ► A = BCD, B = ACD, C = ABD, so all the main effects are clear.
- ► AB = CD, AC = BD, AD = BC, ..., AE = BCDE, BE = ACDE, CE = ABDE, DE = ABCE, so only the two-factor interactions including E are clear, all the others aliased with other two-factor interactions.

More Than One Design Generators

Consider the 2^{6-2} design with design generators: E = AB, F = ACD.

- ► We get the defining contrast subgroups:
 I = ABE = ACDF = BCDEF.
- ► A_i: the number of words of length *i* in its defining contrast subgroup, wordlength pattern W = (A₃, A₄, ..., A_k).
- ► Resolution: the smallest r such that A_r ≥ 1, i.e., the length of the shortest word in the defining contrast subgroup.
- The above design, resolution R = 3 and W = (1, 1, 1, 0, 0, ...).
- Maximum Resolution Criterion: Box and Hunter (1961).
- ▶ Resolution III design, some main effects are not clear.
- Resolution IV design, main effects are clear, those with the largest number of clear two-factor interactions are the best.
- Resolution V design, two-factor interactions are clear.

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Minimum Aberration Criterion

- ► Question: for the same r^{k-p} designs d₁ and d₂ with different design generators, which one is better?
- ► Consider the following two 2⁷⁻² designs:

$$d_1$$
: $I = 4567 = 12346 = 12357$,

- d_2 : I = 1236 = 1457 = 234567.
- ► Fries and Hunter (1980): For any two 2^{k-p} designs d₁ and d₂, let r be the smallest integer such that A_r(d₁) ≠ A_r(d₂). Then d₁ is said to have less aberration than d₂ if A_r(d₁) < A_r(d₂). If there is no design with less aberration than d₁, then d₁ has minimum aberration.

For the above d_1 and d_2 , we have wordlength patterns: $W(d_1) = (0, 1, 2, 0, 0),$ $W(d_2) = (0, 2, 0, 1, 0),$ so d_1 is better than d_2 .

Maximum Number of Clear Effects Criterion

- For the above d_1 and d_2 , we have: $A_3(d_1) = A_3(d_2) = 0$, $A_4(d_1) = 6 < A_4(d_2) = 7$, so d_1 is better than d_2 from minimum aberration criterion.
- ▶ While all the 9 main effects in d₁ and d₂ are clear, d₂ has 15 clear two-factor interactions but d₁ has only 8, so one would judge that d₂ is better than d₁.

Experiments at Mixed Levels

- ▶ When r = 3, $A \times B$: AB, AB^2 , $A \times B \times C$: $ABC, ABC^2, AB^2C, AB^2C^2$.
- Consider a 2³⁻¹ × 3³⁻¹ (asymmetric) product design:
 d₁: C = AB for the two-level factors A, B, C; I = ABC.
 d₂: D = EF for the three-level factors D, E, F; I = DEF².
- Type 1: find 3 aliasing relations A₁, A₂, A₃ of the two-level factors A, B, C, from C = AB:
 A₁: A = BC
 A₂: B = AC
 A₃: C = AB
- Type 2: find 4 aliasing relations B₁, B₂, B₃, B₄ of the three-level factors D, E, F, from D = EF:
 B₁: D = DE²F = EF²
 B₂: E = DF² = DE²F²
 B₃: F = DE = DEF
 B₄: DE² = DF = EF.

Experiments at Mixed Levels (Continued)

• Type 3: find 12 aliasing relations C_1 to C_{12} from Type 1 and Type 2 aliasing relations: C_1 (from A_1 and B_1): $AD = ADE^2F = AEF^2 = BCD = BCDE^2 = BCDEF^2$. C_2 (from A_1 and B_2): $AE = ADF^2 = ADE^2F^2 = BCE = BCDF^2 = BCDE^2F^2$. C_3 : AF = ADE = ADEF = BCF = BCDE = BCDEF. C_{4} : $ADE^{2} = ADF = AEF = BCDE^{2} = BCDF = BCEF$. C_5 : $BD = BDE^2F = BEF^2 = ACD = ACDE^2F = ACEF^2$. C_6 : $BE = BDF^2 = BDE^2F^2 = ACE = ACDF^2 = ACDE^2F^2$. C_7 : BF = BDE = BDEF = ACF = ACDE = ACDEF. C_8 : $BDE^2 = BDF = BEF = ACDE^2 = ACDF = ACEF$. C_0 : $CD = CDE^2F = CEF^2 = ABD = ABDE^2F = ABEF^2$. C_{10} : $CE = CDF^2 = CDE^2F^2 = ABE = ABDF^2F = ABDE^2F^2$. C_{11} : CF = CDE = CDEF = ABF = ABDE = ABDEF. C_{12} : $CDE^2 = CDF = CEF = ABDE^2 = ABDF = ABEF$.

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Orthogonal Array Construction Problem

Problem: given factors vector, R, how to construct the orthogonal array (OA) (design matrix) that has the minimum possible run size n?

- ▶ *R*=3 or *R*=4 for symmetric design.
- ► For asymmetric design, we define R = min(R₁, R₂, ..., R_m). Sometimes have to be R = 1.
- ▶ level=(r₁,..., r₁, r₂,..., r₂,..., r_k,..., r_m). For example, level=(2,2,2,3,3,3,3) or level=(2,2,2,2,3,3,3).
- ▶ minimum possible run size n ⇒ minimum possible run size vector n = (n₁, n₂, ..., n_m) ⇔ maximum possible p = (p₁, p₂, ..., p_m).
- ▶ Get (OA₁, OA₂, ..., OA_m), then cross them together to get the (asymmetric) product design OA.

Maximum Possible p Table

Problem: in each symmetric group, given r, k, R, how to get the maximum possible p? For r=2:

	k	3	4	4	5	5	5	6	6	6	6
	R	3	3(1)	4	3	4(1)	5	3	4	5	6
1	k R max p	1	1*	1	2	1*	1	3	2	2	1

For *r*=3:

k	3	4	4	5	5	5	6	6	6	6
k R max p	3	3	4	3	4	5	3	4	5	6
max p	1	2	1	2	2	1	3	3	2	1

Notice: For r = 2, it might be not compatible for some given R. FYI, for (2,2,2,2) and R = 3, we can only assign 1 design generator 3 = 12, then factor 4 will be the extra factor.

An Example

No.	А	В	С	D
1	—	+	—	+
2	+	+	+	+
3	_	_	+	+
4	+	—	—	+
5	—	+	_	_
6	+	+	_	-
7	_	—	_	-
8	+	_	_	-

- For factors A, B, C, it is a 2^{3−1} design with design generator C = AB, and D is the extra factor. A, B, C, D makes a
- $2^{3-1} \times 2$ product design.
- It is a design with $R = min(R_1, R_2) = min(3, 1) = 1$.

Orthogonal Array Construction Algorithm

Inputs and outputs of the function codes:

- ▶ Input: level vector, *R*.
- ▶ Output: OA (*OA*₁, *OA*₂, ..., *OA*_m are intermediate outputs).

Algorithm:

(1) From R, generator all the possible resolution combination vector $(R_1, R_2, ..., R_m)$.

(2) In each symmetric group (given r, k, R_i), check the compatibility of the given level and resolution R_i .

- If not, stop.
- If yes, continue to step (2).

(3) In each symmetric group (given r, k, R_i), find the maximum possible p.

(4) In each symmetric design (given r, k, p_i), get all the possible design generators (d.g).

Orthogonal Array Construction Algorithm (Continued)

(5) In each symmetric design (given r, k, d.g), from all the possible design generators, get the one which can achieves the minimum aberration.

- ► For each possible design generators, get the wordlength.
- Rank all the wordlengths through minimum aberration criterion.
- Pick up the best wordlength, find its corresponding design generators (d.g_o).
- (6) In each symmetric design (given r, k, $d.g_o$), generate the OA_i . (7) Cross all the OA_i s to get the product design OA.

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- We introduce the basic ideas of fractional factorial design, design generators and minimum aberration criterion.
- We generalize all the ideas from symmetric design to asymmetric (mixed-level) design.
- We provide an algorithm to generate the orthogonal array based on the minimum aberration criterion.

References

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